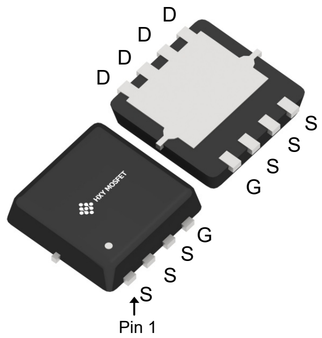
Description

The SQS160ELNW-T1_GE3 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

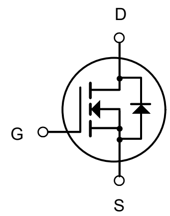


DFN3X3-8L

General Features

V_{DS} = 60V I_D = 100A

$R_{DS(ON)}$ < 4 mΩ @ V_{GS}=20V



N-Channel MOSFET

Application

Battery protection

Load switch

Uninterruptible power supply

Ordering Information

Product ID	Pack	Brand	Qty(PCS)
SQS160ELNW-T1_GE3	DFN3X3-8L	HXY MOSFET	5000

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
I_D@T_C=25°C	Continuous Drain Current, V_{GS} @ 10V	100	A
I_D@T_C=100°C	Continuous Drain Current, V_{GS} @ 10V	64	A
I_{DM}	Pulsed Drain Current	385	A
EAS	Single Pulse Avalanche Energy	80	mJ
I_{AS}	Avalanche Current	22	A
P_D@T_C=25°C	Total Power Dissipation	73.5	W
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C
$R_{\theta JA}$	Thermal Resistance Junction-Ambient	51	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case	1.7	°C/W

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Parameter		Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage		$V_{(BR)DSS}$	V_{GS} = 0V, I_D = 250μA	60	-	-	V
Gate-body Leakage Current		I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V	-	-	±100	nA
Zero Gate Voltage Drain Current	T_J=25°C	I_{DSS}	V_{DS} = 60V, V_{GS} = 0V	-	-	1	μA
	T_J=100°C			-	-		
Gate-Threshold Voltage		$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250μA	1.2	1.7	2.5	V
Drain-Source On-Resistance[4]		$R_{DS(on)}$	V_{GS} = 10V, I_D = 21A	-	4.0	4.8	mΩ
			V_{GS} = 4.5V, I_D = 10A	-	5.2	6.6	
For ward Transconductance[4]		g_{fs}	V_{DS} = 10V, I_D = 21A	-	89	-	S
Input Capacitance		C_{iss}	V_{DS} = 30V, V_{GS} =0V, f =1MHz	-	2180	-	pF
Output Capacitance		C_{oss}		-	735	-	
Reverse Transfer Capacitance		C_{rss}		-	42	-	
Gate Resistance		R_g	f = 1MHz	-	1.8	-	Ω
Total Gate Charge		Q_g	V_{GS} = 10V, V_{DS} = 30V, I_D= 21A	-	35	-	nC
Gate-Source Charge		Q_{gs}		-	6.6	-	
Gate-Drain Charge		Q_{gd}		-	8.4	-	
Turn-On Delay Time		$t_{d(on)}$	V_{GS} = 10V, V_{DD} = 30V, R_G = 3Ω, I_D= 21A	-	9.4	-	ns
Rise Time		t_r		-	8.4	-	
Turn-Off Delay Time		$t_{d(off)}$		-	32.5	-	
Fall Time		t_f		-	12.5	-	
Body Diode Reverse Recovery Time		t_{rr}	I_F= 20A, dI/dt=100A / μs	-	50	-	ns
Body Diode Reverse Recovery Charge		Q_{rr}		-	20	-	nC
Diode Forward Voltage[4]		V_{SD}	I_S = 21A, V_{GS} = 0V	-	-	1.2	V
Continuous Source Current	T_C=25° C	I_S	-	-	-	100	A

Notes:

1. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$=150°C
2. The EAS data shows Max. rating . The test condition is V_{DD}=25V,V_{GS}=10V,L=0.1mH，I_{AS}=40A.
3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
4. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
5. This value is guaranteed by design hence it is not included in the production test.

Typical Characteristics

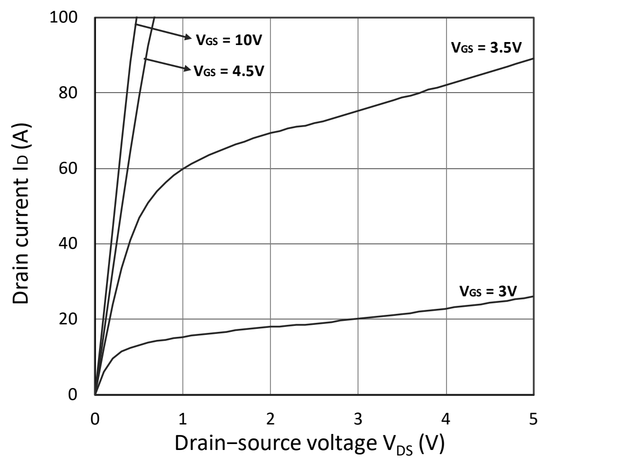


Figure 1. Output Characteristics

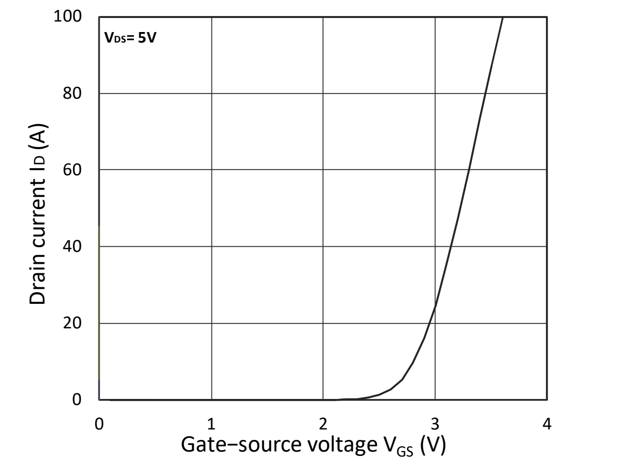


Figure 2. Transfer Characteristics

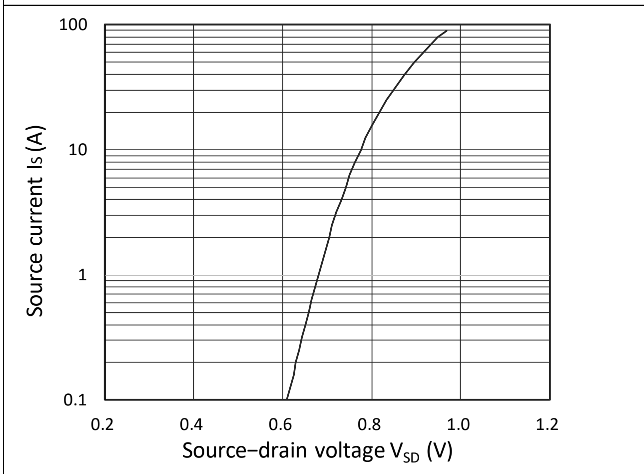


Figure 3. Forward Characteristics of Reverse

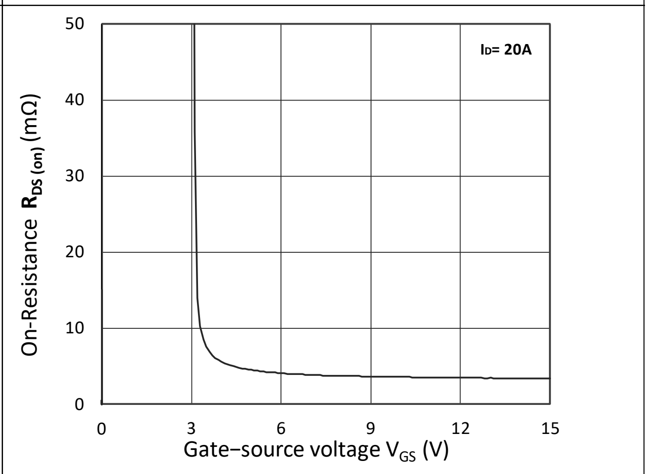


Figure 4. $R_{DS(ON)}$ vs. V_{GS}

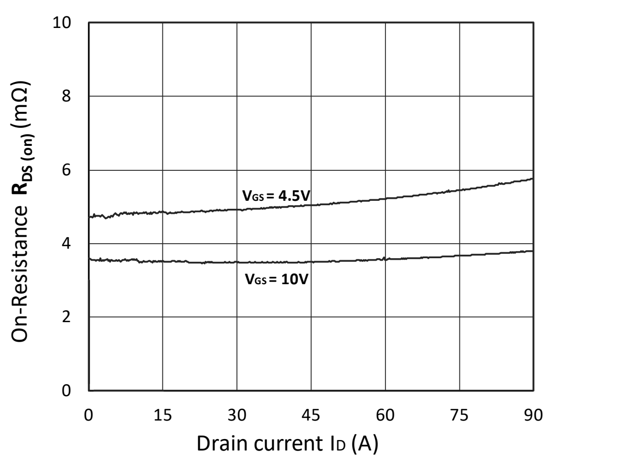


Figure 5. $R_{DS(ON)}$ vs. I_D

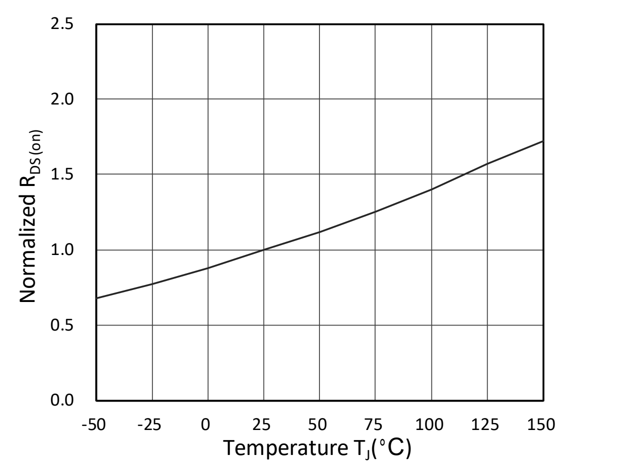
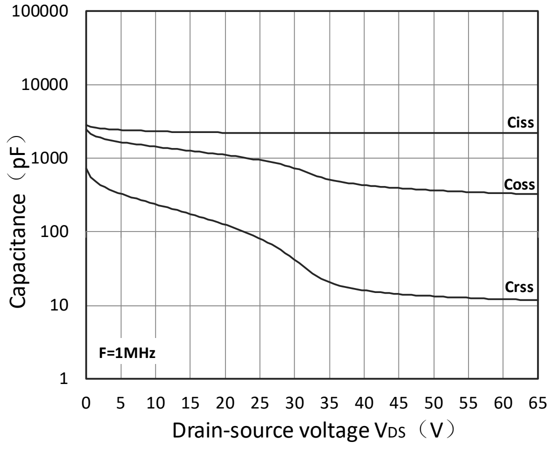


Figure 6. Normalized $R_{DS(on)}$ vs. Temperature



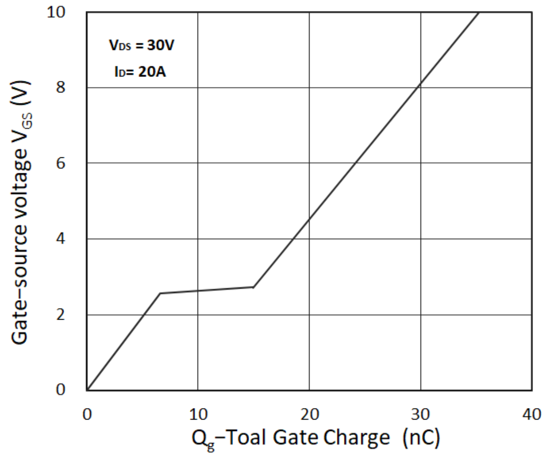
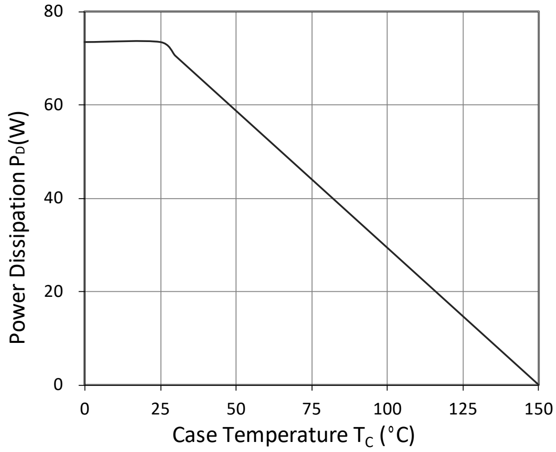


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics



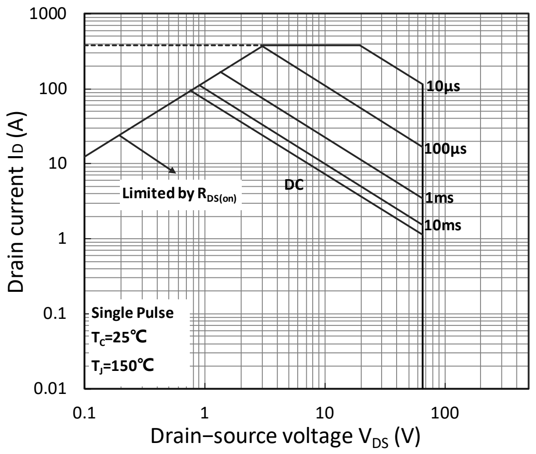


Figure 9. Power Dissipation

Figure10. Safe Operating Area

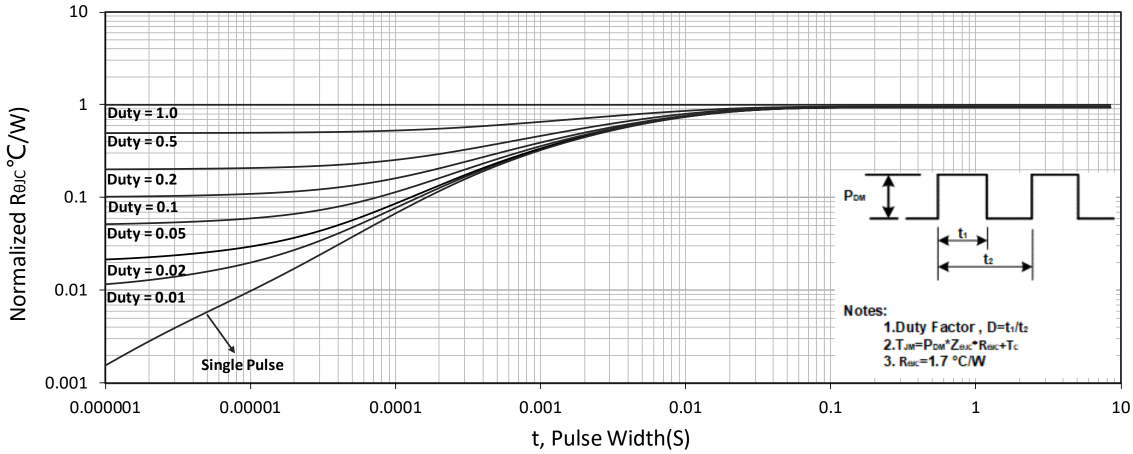


Figure 11. Normalized Maximum Transient Thermal Impedance

Test Circuit

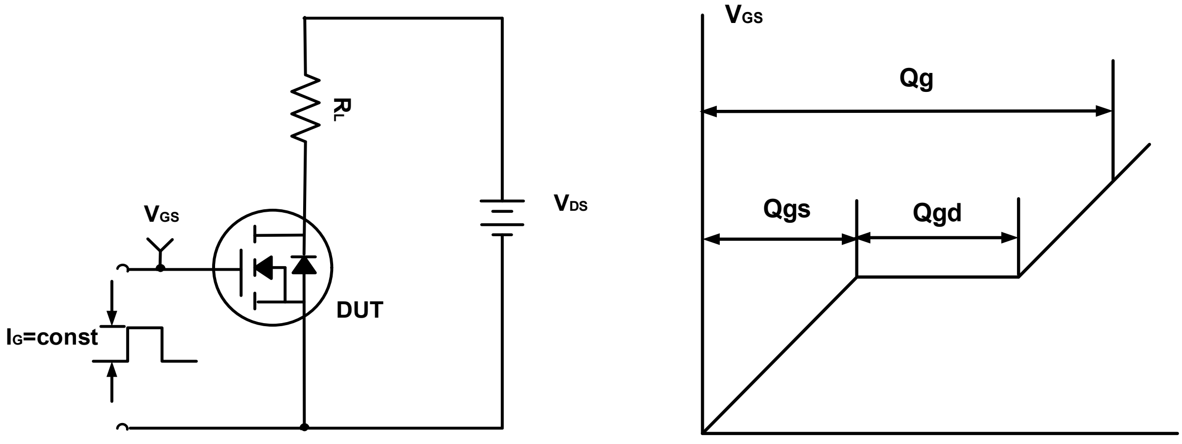


Figure A. Gate Charge Test Circuit & Waveforms

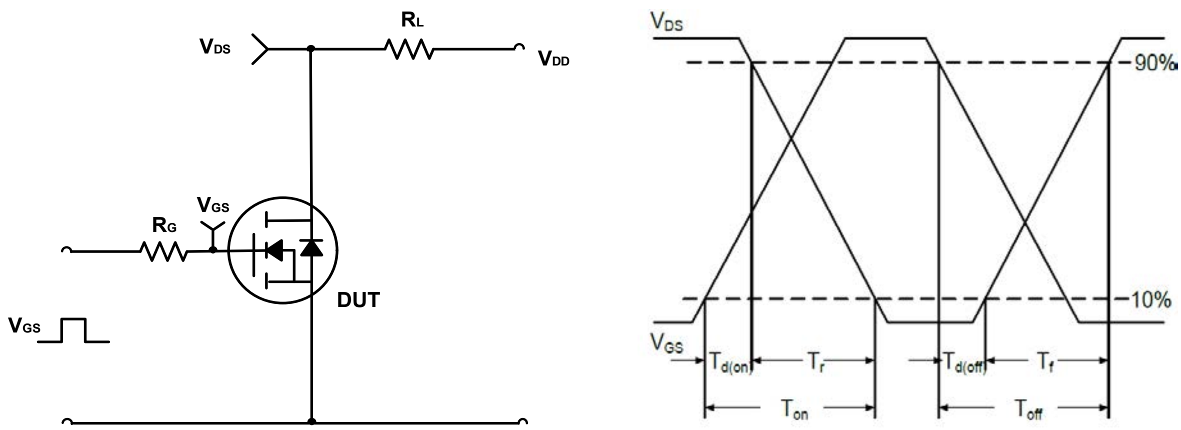


Figure B. Switching Test Circuit & Waveforms

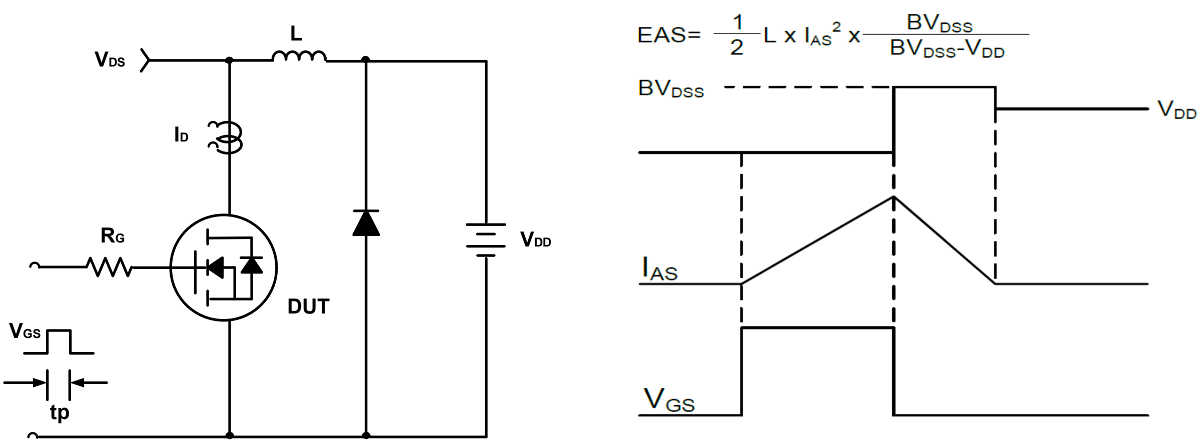
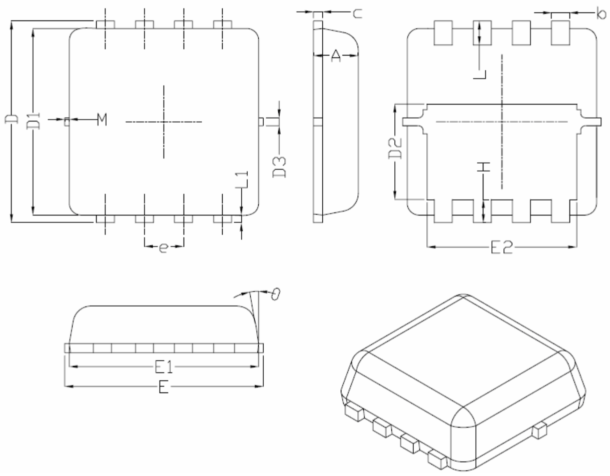


Figure C. Unclamped Inductive Switching Circuit & Waveforms

DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters		
	Min.	Nom.	Max.
A	0.70	0.75	0.80
b	0.25	0.30	0.35
c	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.48	1.58	1.68
D3	-	0.13	-
E	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
e	0.65BSC		
H	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	-	0.13	-
M	*	*	0.15
θ		10°	12°

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